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#### **DUAL 80V NPN & 70V PNP LOW SATURATION TRANSISTOR COMBINATION**

#### **Features and Benefits**

#### **NPN Transistor**

- BV<sub>CEO</sub> > 80V
- I<sub>C</sub> = 3.5A Continuous Collector Current
- Low Saturation Voltage (185mV max @ 1A)
- R<sub>SAT</sub> = 68mΩ for a low equivalent On-Resistance

#### PNP Transistor

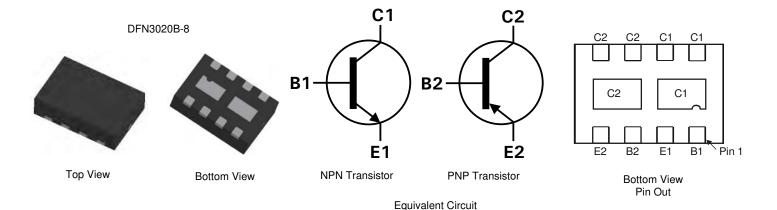
- BV<sub>CEO</sub> > -70V
- I<sub>C</sub> = -2.5A Continuous Collector Current
- Low Saturation Voltage (-220mV max @ -1A)
- $R_{SAT} = 117m\Omega$  for a low equivalent On-Resistance
- h<sub>FE</sub> characterized up to -5A for high current gain hold up
- Low profile 0.8mm high package for thin applications
- R<sub>0JA</sub> efficient, 40% lower than SOT26
- 6mm² footprint, 50% smaller than TSOP6 and SOT26
- Lead-Free, RoHS Compliant (Note 1)
- Halogen and Antimony Free. "Green" Device (Note 2)
- Qualified to AEC-Q101 Standards for High Reliability

#### **Mechanical Data**

- Case: DFN3020B-8
- Case Material: Molded Plastic. "Green" Molding Compound.
- Terminals: Pre-Plated NiPdAu leadframe.
- Nominal package height: 0.8mm
- UL Flammability Rating 94V-0
- Moisture Sensitivity: Level 1 per J-STD-020
- Weight: 0.013 grams (approximate)

### **Applications**

- DC DC Converters
- · Charging circuits
- Power switches
- Motor control
- Portable applications



## Ordering Information (Note 3)

Product	Marking	Reel size (inches)	Tape width (mm)	Quantity per reel
ZXTC6720MCTA	DE4	7	8	3,000

Notes:

- 1. No purposefully added lead.
- 2. Diodes Inc's "Green" Policy can be found on our website at http://www.diodes.com
- 3. For Packaging Details, go to our website at http://www.diodes.com.

## **Marking Information**



DE4 = Product type marking code Top View, Dot Denotes Pin 1





### Maximum Ratings @ T<sub>A</sub> = 25°C unless otherwise specified

Parameter	Symbol	NPN	PNP	Unit		
Collector-Base Voltage		V <sub>CBO</sub>	100	-70		
Collector-Emitter Voltage		V <sub>CEO</sub>	80	-70	7 v	
Emitter-Base Voltage		$V_{EBO}$	7	-7	]	
Peak Pulse Current		I <sub>CM</sub>	5	-3		
Continuous Collector Current	(Notes 4 & 7)	1-	3.5	-2.5	^	
(Notes 5 & 7)		IC	4	-3	A	
Base Current		I <sub>B</sub>		1		

## Thermal Characteristics @ TA = 25°C unless otherwise specified

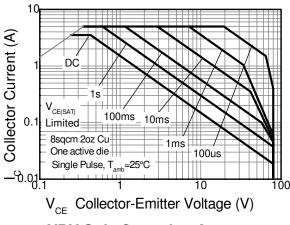
Characteristic	Symbol	NPN	PNP	Unit	
	(Notes 4 & 7)		1.5 12	W mW/°C	
Power Dissipation	(Notes 5 & 7)		2.45 19.6 1.13 8 1.7 13.6		
Linear Derating Factor	(Notes 6 & 7)	- P <sub>D</sub>			
	(Notes 6 & 8)	-			
	(Notes 4 & 7)		83.3 51.0		
The word Decistors of Lunction to Austriant	(Notes 5 & 7)				
Thermal Resistance, Junction to Ambient	(Notes 6 & 7)	$R_{ hetaJA}$	111	111 73.5	
	(Notes 6 & 8)		73.5		
Thermal Resistance, Junction to Lead (Notes 7 & 9)		$R_{ heta JL}$	17.1		
Operating and Storage Temperature Range	T <sub>J</sub> , T <sub>STG</sub>	-55 to +	-150	°C	

Notes:

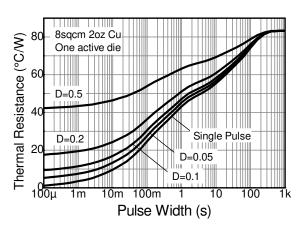
- 4. For a dual device surface mounted on 28mm x 28mm (8cm²) FR4 PCB with high coverage of single sided 2 oz copper, in still air conditions; the device is measured when operating in a steady-state condition. The heatsink is split in half with the exposed collector pads connected to each half.
- 5. Same as note (4), except the device is measured at t <5 sec.
- 6. Same as note (4), except the device is surface mounted on 31mm x 31mm (10cm²) FR4 PCB with high coverage of single sided 1oz copper.
- 7. For a dual device with one active die.
- 8. For dual device with 2 active die running at equal power.
- 9. Thermal resistance from junction to solder-point (at the end of the collector lead).



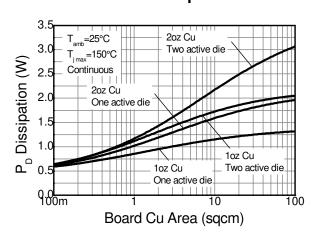
#### **Thermal Characteristics**



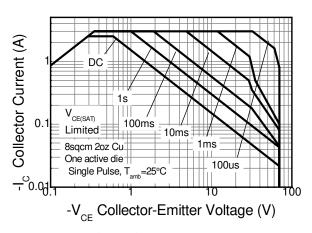
# **NPN Safe Operating Area**



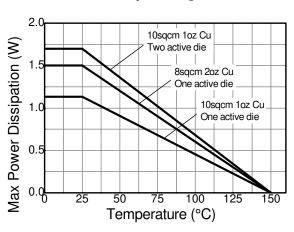
### **Transient Thermal Impedance**



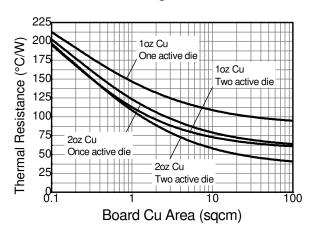
Power Dissipation v Board Area



## **PNP Safe Operating Area**



### **Derating Curve**



Thermal Resistance v Board Area





# **Electrical Characteristics, NPN Transistor** (at T<sub>A</sub> = 25°C unless otherwise specified)

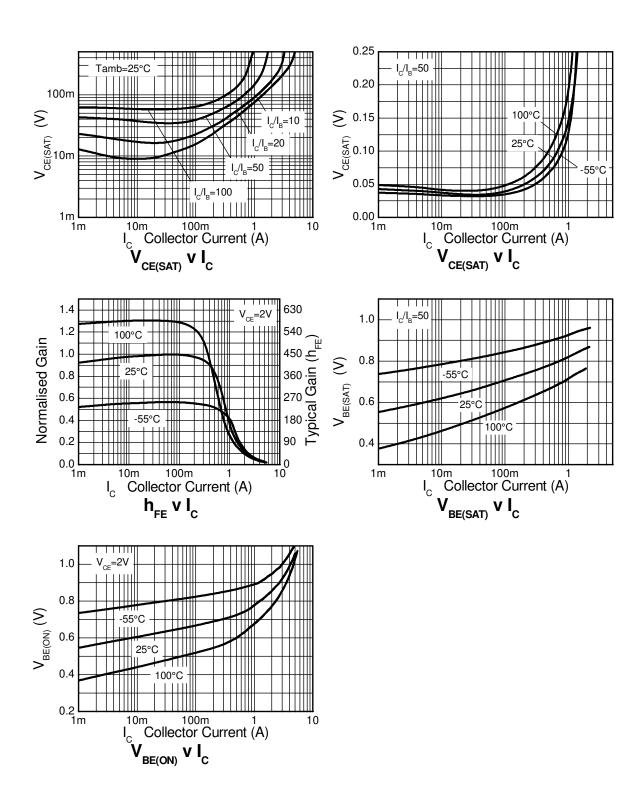
Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition
Collector-Base Breakdown Voltage	$BV_CBO$	100	180	-	٧	$I_C = 100\mu A$
Collector-Emitter Breakdown Voltage (Note 10)	BV <sub>CEO</sub>	80	110	-	V	$I_C = 10mA$
Emitter-Base Breakdown Voltage	BV <sub>EBO</sub>	7	8.2	-	V	$I_E = 100\mu A$
Collector Cutoff Current	I <sub>CBO</sub>	-	-	100	nA	V <sub>CB</sub> = 80V
Emitter Cutoff Current	I <sub>EBO</sub>	-	-	100	. nA	$V_{EB} = 6V$
Collector Emitter Cutoff Current	I <sub>CES</sub>	-	-	100	nA	V <sub>CE</sub> = 65V
Static Forward Current Transfer Ratio (Note 10)	h <sub>FE</sub>	200 300 110 60 20	450 450 170 90 30 10	- 900 - - - -	-	$\begin{split} &I_{C} = 10 \text{mA}, \ V_{CE} = 2 \text{V} \\ &I_{C} = 200 \text{mA}, \ V_{CE} = 2 \text{V} \\ &I_{C} = 1 \text{A}, \ V_{CE} = 2 \text{V} \\ &I_{C} = 1.5 \text{A}, \ V_{CE} = 2 \text{V} \\ &I_{C} = 3 \text{A}, \ V_{CE} = 2 \text{V} \\ &I_{C} = 5 \text{A}, \ V_{CE} = 2 \text{V} \end{split}$
Collector-Emitter Saturation Voltage (Note 10)	V <sub>CE(sat)</sub>	- - - -	15 45 145 160 240	20 60 185 200 340	mV	$\begin{split} I_C &= 0.1\text{A}, \ I_B = 10\text{mA} \\ I_C &= 0.5\text{A}, \ I_B = 50\text{mA} \\ I_C &= 1\text{A}, \ I_B = 20\text{mA} \\ I_C &= 1.5\text{A}, \ I_B = 50\text{mA} \\ I_C &= 3.5\text{A}, \ I_B = 300\text{mA} \end{split}$
Base-Emitter Turn-On Voltage (Note 10)	$V_{BE(on)}$	-	0.96	1.05	V	$I_C = 3.5A, V_{CE} = 2V$
Base-Emitter Saturation Voltage (Note 10)	$V_{BE(sat)}$	-	1.09	1.175	<b>V</b>	$I_C = 3.5A$ , $I_B = 300mA$
Output Capacitance	$C_obo$	-	11.5	18	pF	V <sub>CB</sub> = 10V. f = 1MHz
Transition Frequency	f <sub>T</sub>	100	160	-	MHz	V <sub>CE</sub> = 10V, I <sub>C</sub> = 50mA, f = 100MHz
Turn-on Time	t <sub>on</sub>	-	86	-	ns	V <sub>CC</sub> = 10V, I <sub>C</sub> = 1A
Turn-off Time	t <sub>off</sub>	-	1128	-	ns	$I_{B1} = I_{B2} = 25mA$

Notes: 10. Measured under pulsed conditions. Pulse width  $\leq$  300 $\mu$ s. Duty cycle  $\leq$  2%.





# **NPN - Typical Electrical Characteristics**







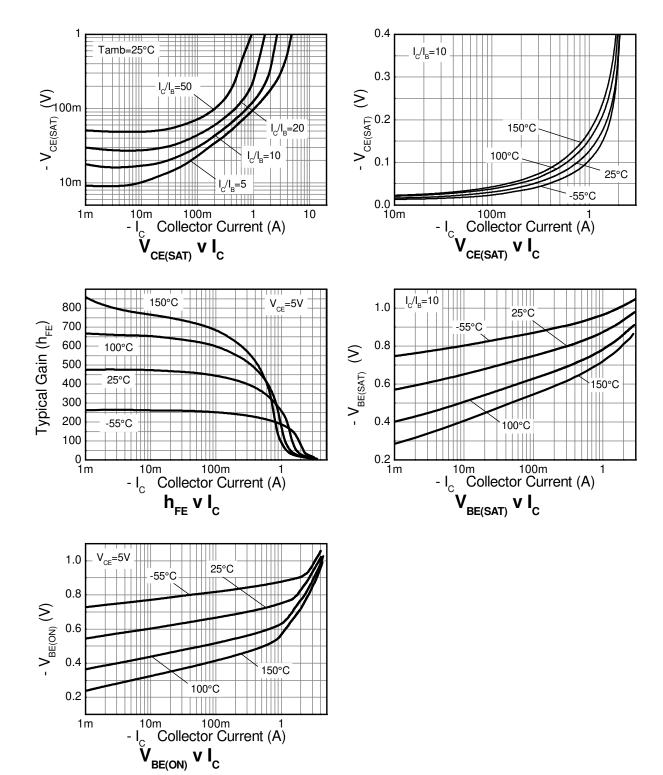
**PNP - Electrical Characteristics**  $@T_A = 25^{\circ}C$  unless otherwise specified

Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition
Collector-Base Breakdown Voltage	$V_{(BR)CBO}$	-70	-150	-	V	$I_C = -100 \mu A$
Collector-Emitter Breakdown Voltage (Note 11)	$V_{(BR)CEO}$	-70	-125	-	V	$I_C = -10mA$
Emitter-Base Breakdown Voltage	$V_{(BR)EBO}$	-7	-8.5	-	V	$I_E = -100 \mu A$
Collector Cutoff Current	I <sub>CBO</sub>	-	-	-100	nA	$V_{CB} = -55V$
Emitter Cutoff Current	I <sub>EBO</sub>	-	-	-100	. nA	$V_{EB} = -6V$
Collector Emitter Cutoff Current	I <sub>CES</sub>	-	-	-100	nA	V <sub>CE</sub> = -55V
Static Forward Current Transfer Ratio (Note 11)	h <sub>FE</sub>	200 300 175 40	470 450 275 60 10		-	$\begin{split} I_{C} &= -10 \text{mA}, \ V_{CE} = -5 \text{V} \\ I_{C} &= -100 \text{mA}, \ V_{CE} = -5 \text{V} \\ I_{C} &= -1A, \ V_{CE} = -5 \text{V} \\ I_{C} &= -1.5A, \ V_{CE} = -5 \text{V} \\ I_{C} &= -3A, \ V_{CE} = -5 \text{V} \end{split}$
Collector-Emitter Saturation Voltage (Note 11)	V <sub>CE(sat)</sub>	- - -	-35 -135 -140 -175	-50 -200 -220 -270	mV	$I_C = -0.1A$ , $I_B = -10mA$ $I_C = -0.5A$ , $I_B = -20mA$ $I_C = -1.0A$ , $I_B = -100mA$ $I_C = -1.5A$ , $I_B = -200mA$
Base-Emitter Turn-On Voltage (Note 11)	$V_{BE(on)}$	-	0.78	1.00	V	$I_C = -1.5A$ , $V_{CE} = -5V$
Base-Emitter Saturation Voltage (Note 11)	$V_{BE(sat)}$	-	0.94	1.05	V	$I_C = -1.5A$ , $I_B = -200mA$
Output Capacitance	$C_{ m obo}$	-	14	20	pF	$V_{CB} = -10V. f = 1MHz$
Transition Frequency	f <sub>T</sub>	150	180	-	MHz	$V_{CE} = -10V$ , $I_{C} = -50mA$ , $f = 100MHz$
Turn-on Time	t <sub>on</sub>	-	40	-	ns	$V_{CC} = -50V, I_{C} = -1A$
Turn-off Time	t <sub>off</sub>	-	700	-	ns	$I_{B1} = I_{B2} = -50 \text{mA}$

Notes: 11. Measured under pulsed conditions. Pulse width  $\leq 300 \mu s.$  Duty cycle  $\leq~2\%.$ 



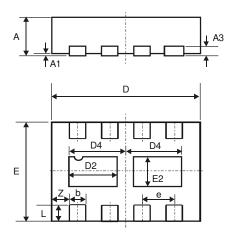
# **PNP - Typical Electrical Characteristics**





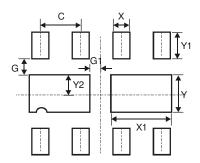


# **Package Outline Dimensions**



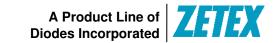
DFN3020B-8						
Dim	Min	Max	Тур			
Α	0.77	0.83	0.80			
A1	0	0.05	0.02			
A3	1	-	0.15			
b	0.25	0.35	0.30			
D	2.95	3.075	3.00			
D2	0.82	1.02	0.92			
D4	1.01	1.21	1.11			
е	-	-	0.65			
Е	1.95	2.075	2.00			
E2	0.43	0.63	0.53			
L	0.25	0.35	0.30			
Z	-	-	0.375			
All Dimensions in mm						

# **Suggested Pad Layout**



Dimensions	Value (in mm)
С	0.650
G	0.285
G1	0.090
Х	0.400
X1	1.120
Υ	0.730
Y1	0.500
Y2	0.365





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